



TOLSA  
Toulouse Open Laboratory for Semiconductor Analysis



CENTRE NATIONAL D'ÉTUDES SPATIALES



Centres de Compétence Technique



# Session 3 : Static laser Stimulation

**Chairman Sylvain Dudit, ST Crolles**

<i>16:20-16:40</i>	Nanoscale resolution options for optical localization techniques (Christian Boit, TU Berlin)
<i>16:40-16:50</i>	Static Laser Stimulation background (Abdelatif Firiti Freescale Toulouse)
<i>16:50-17:10</i>	3D resolution with MOBIRCH (Antoine Reverdi, NXP Caen)
<i>17:10-17:30</i>	Application of static laser stimulation to MEMS FA (Jeremy Denhin, Novamems France)
<i>17:30-17:50</i>	Case studies using MTLs on FA daily products (Marc De-La-Bardonnie NXP Caen)
<i>17:50-18:10</i>	Relationship of TLS/SIFT tools (Jim Colvin, FA Instruments,
<i>18:10-18:30</i>	Questions and answers (Moderator Kevin Sanchez, CNES Toulouse, France)